AMENDMENTS TO THE CLAIMS

The following listing of claims will replace all prior versions, and listings, of claims in the application:

Listing of Claims:

- (Original) A lead-free and cadmium-free dielectric paste comprising a solids portion wherein the solids portion comprises, prior to firing:
 - a. about 41.5 wt% to about 48.5 wt% SrO,
 - b. about 47 wt% to about 55 wt% ZrO₂,
 - c. about 0.5 wt% to about 2.5 wt% TiO₂,
 - d. about 0.05 wt% to about 1.5 wt% MgO, and
 - e. about 0.05 wt% to about 3 wt% B₂O₃.
- 2. (Original) A method of forming an electronic component comprising:
 - f. applying the dielectric paste of claim 1 to a substrate and
 - g. firing the substrate at a temperature sufficient to sinter the dielectric material.
- (Original) The method of claim 2 wherein the firing is conducted at a temperature of 1200°C-1350°C.

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4. (Original) The method of claim 2 wherein the firing is conducted in an atmosphere having a partial oxygen pressure of about 10⁻¹² atm to about 10⁻⁸ atm.

- 5. (Original) A multilayer ceramic chip capacitor comprising a fired collection of:
 - h. alternately stacked layers of the dielectric material of claim 1 and
 - layers of an internal electrode material comprising a transition metal other than Ag, Au, Pd, or Pt.
- (Original) The multilayer ceramic chip capacitor of claim 5 wherein the internal electrode material comprises nickel.
- 7. (Original) A method of forming an electronic component comprising:
 - i. alternately applying layers of
 - i. an oxide-containing dielectric material comprising the paste of claim 1
 and
 - ii. a metal-containing electrode paste onto
 - iii. a substrate to form a laminar stack,
 - k. firing the substrate at a temperature sufficient to sinter the dielectric material,
 - I. cutting the laminar stack to a predetermined shape,
 - m. separating the cut stack from the substrate, and

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n. firing the stack to sinter the metal in the electrode and fuse the oxides in the

dielectric material, wherein the internal electrode and the dielectric material

each have a layer thickness.

8. (Original) The method of claim 7 wherein the layers of dielectric material, after

firing, have a thickness of about 1 microns to about 50 microns.

9. (Original) The method of claim 7 wherein the firing is conducted at a

temperature of 1200°C to about 1325°C

10. (Original) The method of claim 7 wherein the firing is conducted in an

atmosphere having a partial oxygen pressure of about 10⁻¹² atm to about 10⁻⁸

atm.

11. (Original) The method of claim 7 wherein the metal-containing electrode paste

comprises nickel.

12. (Original) A lead-free and cadmium-free dielectric paste comprising a solids

portion wherein the solids portion comprises, prior to firing:

o. about 44.2 wt% to about 45.6 wt% SrO,

p. about 50.2 wt% to about 51.8 wt% ZrO₂,

q. about 0.1 wt% to about 0.4 wt% MgO,

r. about 1.5 wt% to about 1.6 wt% TiO₂,

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- s. about 0.3 to about 1.2 wt% Al₂O₃,
- t. about 0.5 to about 2.2 wt% SiO₂, and
- u. up to about 0.3 wt% CaO.
- 13. (Original) A method of forming an electronic component comprising:
 - v. applying the dielectric paste of claim 12 to a substrate and
 - w. firing the substrate at a temperature sufficient to sinter the dielectric material.
- 14. (Original) The method of claim 12 wherein the firing is conducted at a temperature of 1200°C-1350°C, and in an atmosphere having a partial oxygen pressure of about 10⁻¹² atm to about 10⁻⁸ atm.
- 15. (Original) A method of forming an electronic component comprising:
 - x. applying particles of a calcined dielectric material to a substrate and
 - y. firing the substrate at a temperature sufficient to sinter the dielectric material,
 - z. wherein the dielectric material comprises, prior to firing, a composition selected from the group consisting of composition 1, composition 2, composition 3, composition 4, wherein prior to calcining,
 - i. composition 1 comprises
 - 1. about 1 wt% to about 7 wt% SrTiO₃,
 - 2. about 89 wt% to about 99 wt% SrZrO₃,
 - 3. about 0.05 wt% to about 3 wt% B₂O₃, and
 - 4. about 0.05 wt% to about 1.5 wt% MgO,

ii. composition 2 comprises

- 1. about 52 wt% to about 56 wt% SrCO₃,
- 2. about 41 wt% to about 45 wt% ZrO₂,
- 3. about 1 wt% to about 2 wt% TiO₂,
- 4. about 0.05 wt% to about 3 wt% B₂O₃, and
- 5. about 0.05 wt% to about 1.5 wt% MgO,

iii. composition 3 comprises

- 1. about 50 wt% to about 58 wt% SrCO₃,
- 2. about 40 wt% to about 46 wt% ZrO₂,
- 3. about 0.5 wt% to about 3 wt% TiO₂,
- about 0.05 to about 1 wt% MgO,
- 5. about 0.05 wt% to about 2 wt% Al_2O_3 ,
- 6. about 0.05 wt% to about 3 wt% SiO₂,
- 7. CaO, provided the amount does not exceed about 1 wt%, and
- 8. SrO, provided the amount does not exceed about 0.5 wt%, and

iv. composition 4 comprises

- 1. about 2 wt% to about 5 wt% SrTiO₃,
- 2. about 90 wt% to about 98 wt% SrZrO₃,
- 3. about 0.05 to about 2 wt% MgO,
- 4. about 0.05 wt% to about 2.5 wt% Al₂O₃,
- 5. about 0.05 wt% to about 3.5 wt% SiO₂,
- 6. SrO, provided the amount does not exceed about 1 wt%, and
- 7. CaO, provided the amount does not exceed about 1 wt%.

- 16. (Original) The method of claim 15 wherein the firing is conducted at a temperature of 1200°C-1350°C.
- 17. (Original) The method of claim 15 wherein the firing is conducted in an atmosphere having a partial oxygen pressure of about 10⁻¹² atm to about 10⁻⁸ atm.
- 18. (Original) The method of claim 15 wherein the firing is conducted at a temperature of 1200°C to about 1325°C.
- 19. (Original) The method of claim 15 wherein the dielectric material comprises, prior to firing, composition 1.
- 20. (Original) The method of claim 15 wherein the dielectric material comprises, prior to firing, composition 3.